Issue	Classification

Application/Control	No

10/612,608 Examiner

Nathan W. Ha

Applicant(s)/Patent under Reexamination

WU, CHI-LONG Art Unit

2814

	18	SSUE CLASSIFICATION
ORIGINAL		CROSS REFERENCE(S)
CLASS SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)
438 108	257	40 41 42 43
INTERNATIONAL CLASSIFICATION	.:1	
HO1 L 21 1 44		
Nathan W. Ha 81 (Assistant Examiner) (Da	31/05 te)	Loay an Total Claims Allowed: 15
M. Brunson (Legal Instruments Examiner)	9/2/05- (Date)	HON PHAM 9/1/05 O.G. O.G. Print Claim(s): Print Fig. (Primary Examiner) (Date)

Claims renumbered in the same order as presented by applicant									□СРА			☐ T.D.			☐ R.1.47				
Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original
	1			31]		61			91			121			151			181
	2			32]		62			92			122			152			182
	3			3 3]		63			93			123			153			183
	4			34			64			94			124			154			184
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2	8			38			68	1		98			128			158			188
3	9	1		39			69	1		99			129			159			189
4	10	1		40	1		70	1		100			130			160	,		190
5	11	1		41	1 .		71	1		101			131			161			191
6	12	1		42	1		72	1		102			132			162			192
7	13	1		43	1 :		73	1		103			133	-		163			193
8	14	1		44			74	1 :		104			134			164			194
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12	19	ĺ		49	ĺ		79	1		109			139	i		169			199
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14	21			51			81	1		111			141	i	·	171			201
15	22			52			82	1		112			142			172			202
	23	1		53			83	1		113		-	143	Ì		173			203
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	25	1		55	ĺ		85	1		115			145	Ì		175			205
	26			56			86	1		116			146			176			206
	27	[57			87	1		117			147			177			207
	28			58			88	1		118			148			178			208
	29	1		59			89	1		119		-	149			179			209
	30			60			90	1		120			150			180			210